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I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to: MailStop AF, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on June 23, 2005.

Sue Bromaghin

June 23, 2005

**CUSTOMER NO. 36257**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:	Wayne CHEN et al.		
Title:	System and Methods for Classifying Anomalies of Sample Surfaces		
Application No.:	10/613,634	Filing Date:	July 3, 2003
Examiner:	Michael P. STAFIRA	Group Art Unit:	2877
Docket No.:	TNCR.178US1	Conf. No.:	4612

Mail Stop AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**TRANSMITTAL OF RESPONSE TO OFFICE ACTION  
AND REQUEST FOR ONE-MONTH EXTENSION OF TIME**

Sir:

Transmitted herewith are the following documents in the above-identified application:

- (1) Return Receipt Postcard;
  - (2) This Transmittal Letter (in duplicate);
  - (3) Response to Final Office Action (for which no claims fee is due);
  - (4) Check for \$120 (extension of time / one month).
- Request is hereby made for a one-month extension of time to file these documents, up to and including **June 25, 2005**.

☒ Please charge any additional fees required or credit any overpayment to Deposit Account No. 502664. This authorization is provided in duplicate.

Respectfully submitted,

06/28/2005 EHAILE1 00000017 10613634

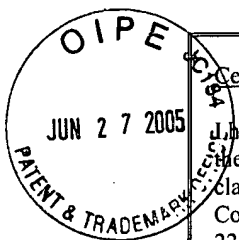
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James S. Hsue  
Reg. No. 29,545

June 23, 2005  
Date

AF  
TJW



**Certificate of Mailing Under 37 CFR 1.8**

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*Sue Bromaghin*  
Sue Bromaghin June 23, 2005

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**RESPONSE TO FINAL OFFICE ACTION**

Sir:

This is in response to the final Office Action dated February 25, 2005, setting a period for response expiring on May 25, 2005. An appropriate request for extension of time accompanies this paper, up to and including June 25, 2005 to file this response.

**Amendments to the Specification** begin on page 2 of this paper.

**Amendments to the Claims** begin on page 3 of this paper.

**Remarks** begin on page 6 of this paper.